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P-Channel 60-V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^a	Q _g (Typ.)			
- 60	0.024 at V _{GS} = - 10 V	- 10	7.6 nC			
- 60	0.031 at V _{GS} = - 4.5 V	- 8	7.0110			

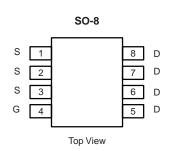
FEATURES

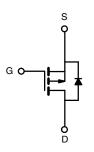
- DT-Trench Power MOSFET
- 100 % UIS Tested

RoHS

APPLICATIONS

Load Switch





P-Channel	MOSFET
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ABSOLUTE MAXIMUM RATINGS	S (T _A = 25 °C, unle	ess otherwise not	ed)		
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V _{DS}	- 60	V		
Gate-Source Voltage		V _{GS}		± 20	
	T _C = 25 °C		- 10 ^a		
Continuous Dusin Comment (T., 150 °C)	T _C = 70 °C		- 6.8		
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	7.2 ^b		
	T _A = 70 °C		- 6.1 ^b	A	
Pulsed Drain Current		I _{DM}	- 30		
Avalanche Current Pulse	L = 0.1 mH	I _{AS}	- 4.5		
Single Pulse Avalanche Energy	L = 0.1 mn	E _{AS}	10.1	mJ	
Continuous Source-Drain Diode Current	T _C = 25 °C	1	6.9 ^a		
	T _A = 25 °C	I _S	2.1 ^b	A	
	T _C = 25 °C		10.4 ^a		
Maximum Power Dissipation	T _C = 70 °C	В	6.6 ^a	w	
	T _A = 25 °C	P _D	1.1 ^b		
	T _A = 70 °C		2 ^b		
Operating Junction and Storage Temperature R	T _J , T _{stg}	- 55 to 150	°C		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^b	Steady State	R_{thJA}	33	40	°C/W	
Maximum Junction-to-Case	Steady State	R _{thJC}	0.98	1.2	- 10/00	

Notes:

- a. Based on T_C = 25 °C.
- b. Surface mounted on 1" x 1" FR4 board.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static					•	•	
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 60			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = - 250 μA		68		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	1 _D = - 250 μA		- 5.2			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 1		- 3	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	1	V _{DS} = - 60 V, V _{GS} = 0 V			- 1		
	IDSS	V _{DS} = - 60 V, V _{GS} = 0 V, T _J = 55 °C			- 10	- μΑ	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} = -5 \text{ V}, V_{GS} = -10 \text{ V}$	- 120			Α	
D : 0	В	V _{GS} = - 10 V, I _D = - 3 A		0.024			
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = -4.5 \text{ V}, I_D = -2 \text{ A}$		0.031		Ω	
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 15 V, I _D = - 5 A	20			S	
Dynamic ^b					•		
Input Capacitance	C _{iss}			3500		pF	
Output Capacitance	C _{oss}	$V_{DS} = -25 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		390			
Reverse Transfer Capacitance	C _{rss}			290			
Tatal Cata Charma	Q_g	$V_{DS} = -30 \text{ V}, V_{GS} = -10 \text{ V}, I_{D} = -5 \text{ A}$		76	115	115 60 nC	
Total Gate Charge				38	60		
Gate-Source Charge	Q_{gs}	$V_{DS} = -30 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -5 \text{ A}$		16			
Gate-Drain Charge	Q_{gd}			19			
Gate Resistance	R_{g}	f = 1 MHz		5.2		Ω	
Turn-On Delay Time	t _{d(on)}			10	15		
Rise Time	t _r	$V_{DD} = -2 V, R_L = 2 \Omega$		7	15	no	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ - 5 A, V_{GEN} = - 10 V, R_g = 1 Ω		70	110	ns -	
Fall Time	t _f			40	60		
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	I_S $T_C = 25 ^{\circ}C$			- 6.9		
Pulse Diode Forward Current ^a	I _{SM}				- 30	A	
Body Diode Voltage	V _{SD}	I _S = - 3 A		- 1	- 1.5	V	
Body Diode Reverse Recovery Time	t _{rr}			45	68	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = - 5 A, di/dt = 10 A/μs, T _J = 25 °C		59	120	nC	
Reverse Recovery Fall Time	t _a	$ 1_F - 3_A, \text{ u/u} = 10_A/\mu \text{s}, 1_J = 25_B$		29			
Reverse Recovery Rise Time	t _b			16		ns	

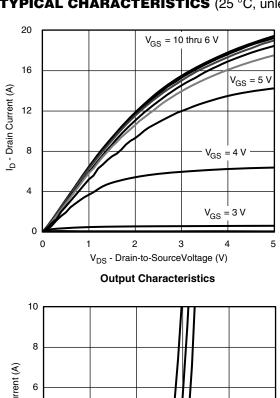
Notes:

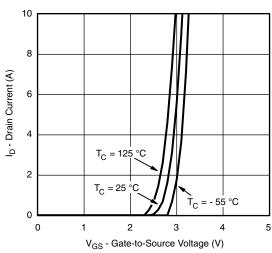
- a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

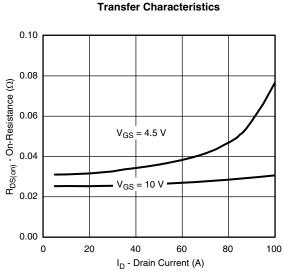
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

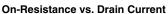


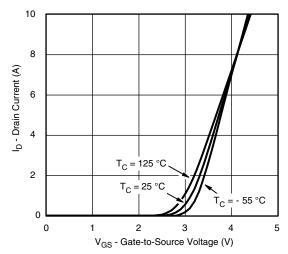
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



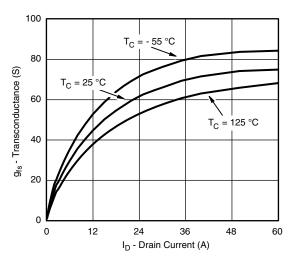




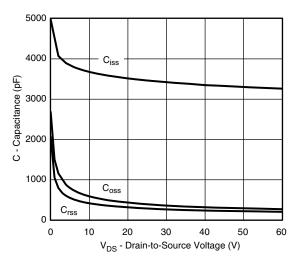








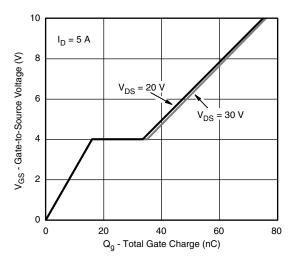
Transconductance



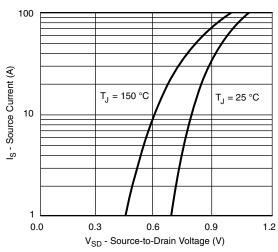
Capacitance



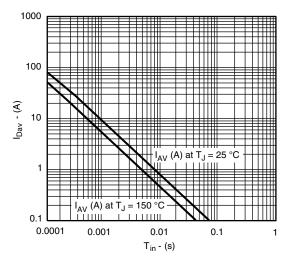
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



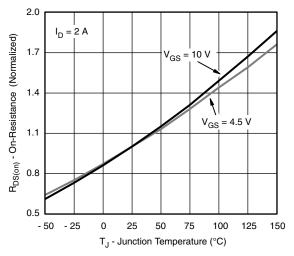
Gate Charge



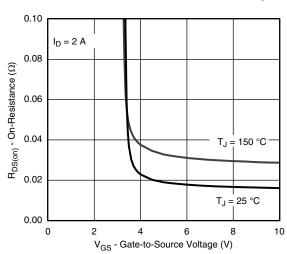
Source-Drain Diode Forward Voltage



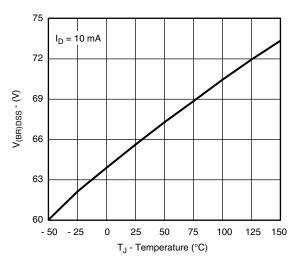
Single Pulse Avalanche Current Capability vs. Time



On-Resistance vs. Gate-to-Source Voltage



On-Resistance vs. Gate-to-Source Voltage

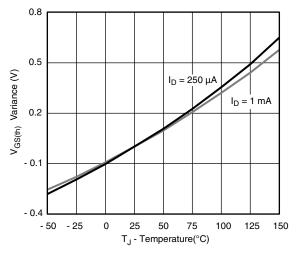


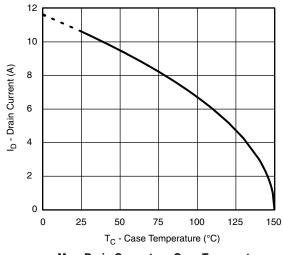
Drain-Source Breakdown Voltage vs. Junction Temperature



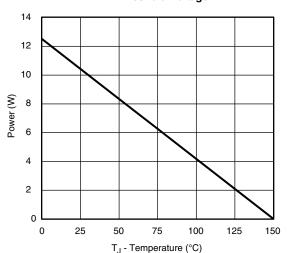


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

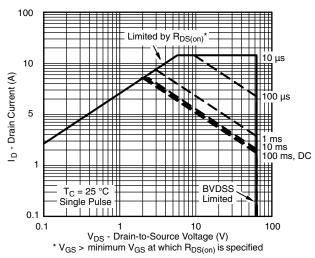






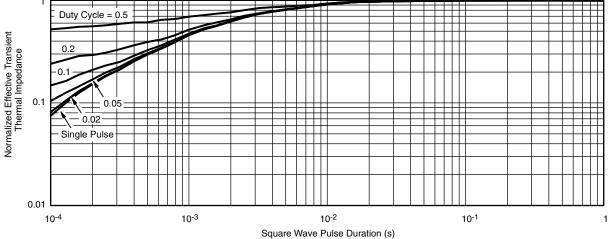


Max. Drain Current vs. Case Temperature



Power Derating, Junction-to-Case

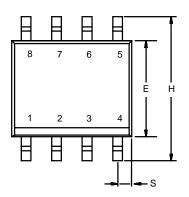


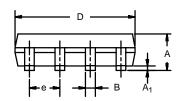


Normalized Thermal Transient Impedance, Junction-to-Case



SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012





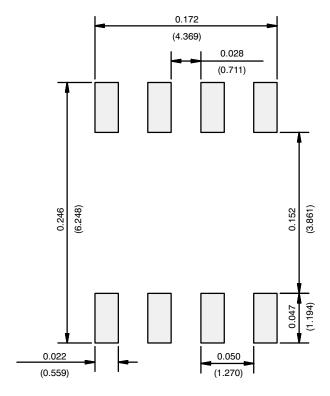


	MILLIMETERS		INC	HES	
DIM	Min	Max	Min	Max	
Α	1.35	1.75	0.053	0.069	
A ₁	0.10	0.20	0.004	0.008	
В	0.35	0.51	0.014	0.020	
С	0.19	0.25	0.0075	0.010	
D	4.80	5.00	0.189	0.196	
E	3.80	4.00	0.150	0.157	
е	1.27 BSC		0.050 BSC		
Н	5.80	6.20	0.228	0.244	
h	0.25	0.50	0.010	0.020	
L	0.50	0.93	0.020	0.037	
q	0°	8°	0°	8°	
S	0.44	0.64	0.018	0.026	
ECN: C-06527-Rev I 11-Sep-06					

ECN: C-06527-Rev. I, 11-Sep-06

DWG: 5498

RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)





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